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Application/Control No.	Applicant(s)/Patent under Reexamination
10/728,108	CHOU ET AL.
Examiner	Art Unit
Anthony Fick	1753

SEARCHED			
Class	Subclass	Date	Examiner
136	253	6/13/2007	ADF
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
See EAST search history	6/13/2007	ADF
Inventor search	6/12/2007	ADF _.
Consulted with Nam Nguyen	6/13/2007	ADF